

TO-252 Plastic-Encapsulate MOSFETS

Features

- $V_{DS}=30V$
- $I_D=80A$
- $R_{DS(on)}@V_{GS}=10V < 5.6m\Omega$
- $R_{DS(on)}@V_{GS}=4.5V < 8m\Omega$
- High density cell design for ultra low Rdson
- Voltage controlled small signal switch
- Fast Switching Speedze

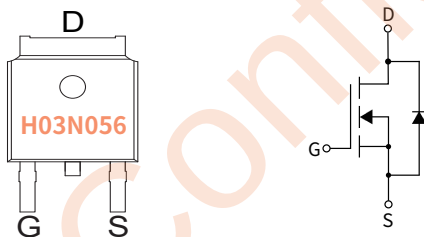
Applications

- Battery protection
- Load switch
- Power management

Mechanical Data

- Case: TO-252
- Molding compound meets UL 94V-0 flammability rating, RoHS-compliant,halogen-free
- Terminals: Solder plated, solderable per MIL-STD-750,Method 2026

Function Diagram



Maximum Ratings (Ta=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	VALUE
Drain-source Voltage	V_{DS}	V	30
Gate-source Voltage	V_{GS}	V	± 20
Drain Current	I_D	A	80
Pulsed Drain Current ⁽¹⁾	I_{DM}	A	320
Total Power Dissipation	P_D	W	43
Single pulse avalanche energy ⁽²⁾	EAS	mJ	90
Junction temperature	T_J	°C	-55 ~+150
Storage temperature	T_{stg}	°C	-55 ~+150
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	°C / W	2.9

Ordering Information

PACKAGE	PACKAGE CODE	UNIT WEIGHT(g)	REEL(pcs)	BOX(pcs)	CARTON(pcs)	DELIVERY MODE
TO-252	R3	0.305	2500	5000	50000	13"

Drain-source Voltage

30 V

Drain Current

80 Ampere



● Static Parameter Characteristics (T_j=25°C Unless otherwise specified)

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D =250μA	V	30	—	—
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =30V, V _{GS} =0V	μA	—	—	1.0
Gate-Body Leakage Current	I _{GSS}	V _{GS} = ±20V, V _{DS} =0V	nA	—	—	±100
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D =250μA	V	1.0	1.8	2.5
Static Drain-Source On-Resistance ⁽³⁾	R _{DS(ON)}	V _{GS} = 10V, I _D =20A	mΩ	—	4.3	5.6
		V _{GS} = 4.5V, I _D =16A		—	6	8

● Dynamic Parameters

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, f=1MHZ	pF	—	2300	—
Output Capacitance	C _{oss}			—	310	—
Reverse Transfer Capacitance	C _{rss}			—	260	—

● Switching Parameters

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Turn-on Delay Time	t _{D(on)}	V _{GS} =10V, V _{DD} =15V, I _D =20A, R _{GEN} =3Ω	nS	—	8.5	—
Turn-on Rise Time	t _r		nS	—	9	—
Turn-off Delay Time	t _{D(off)}		nS	—	31	—
Turn-off fall Time	t _f		nS	—	9	—
Total Gate Charge	Q _g	V _{DS} =15V, I _D =20A V _{GS} =10V	nC	—	38	—
Gate-Source Charge	Q _{gs}		nC	—	5.1	—
Gate-Drain Charge	Q _{gd}		nC	—	12	—

● Drian-Source Diode Characteristics

PARAMETER	SYMBOL	Condition	UNIT	Min	Typ	Max
Diode Forward Voltage	V _{SD}	I _S =20A, V _{GS} =0V	V	—	—	1.2
Maximum Body-Diode Continuous Current	I _S	—	A	—	—	80
Reverse Recovery Time	T _{rr}	I _S =20A, V _{GS} =0V di/dt=500A/μs	nS	—	16	—
Reverse Recovery Charge	Q _{rr}		nC	—	42	—

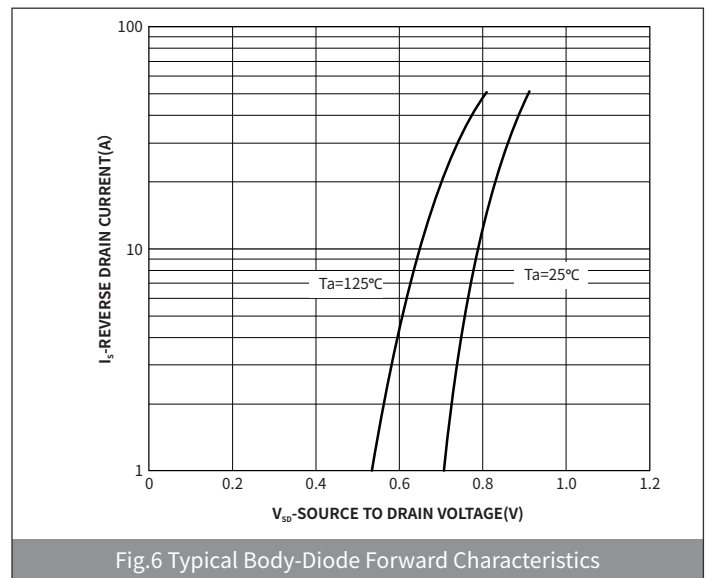
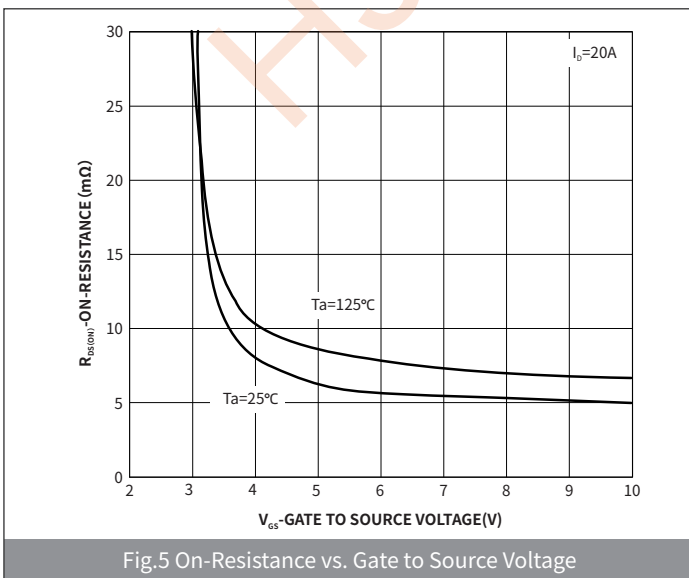
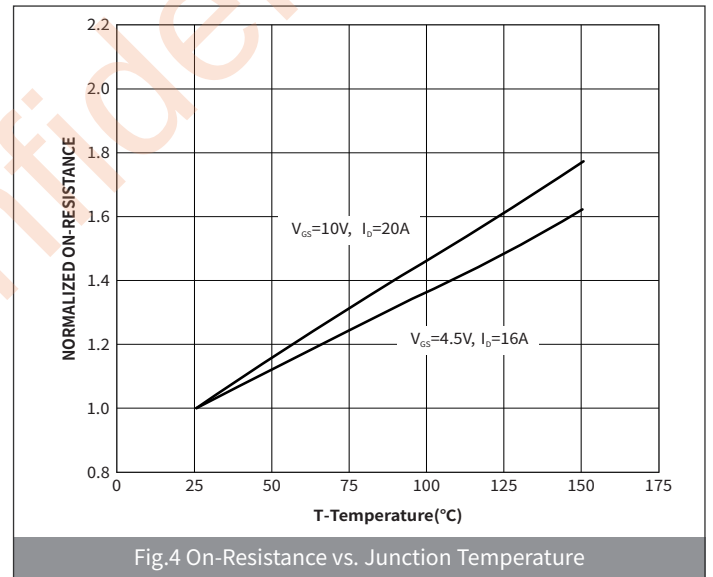
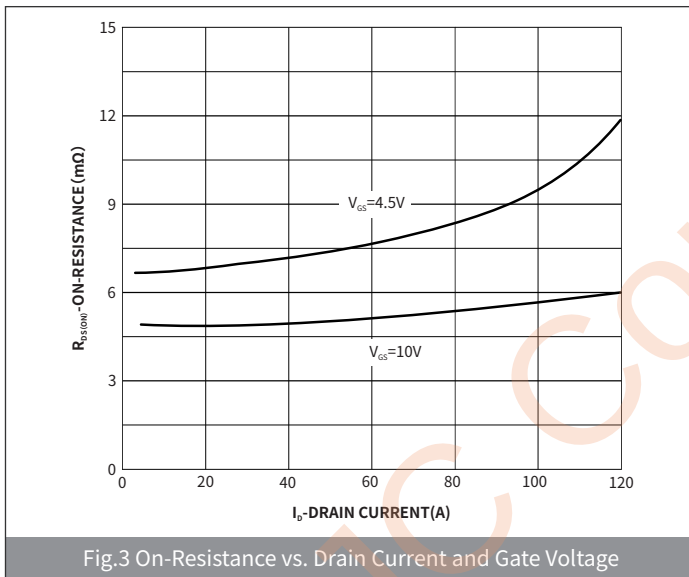
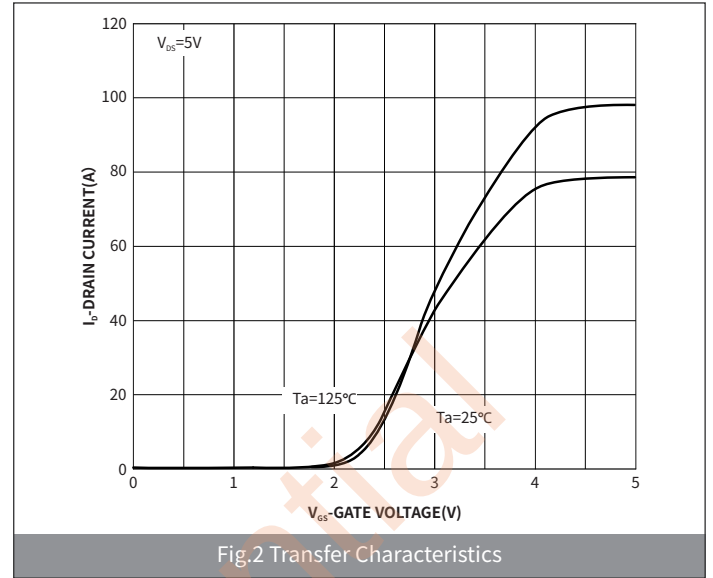
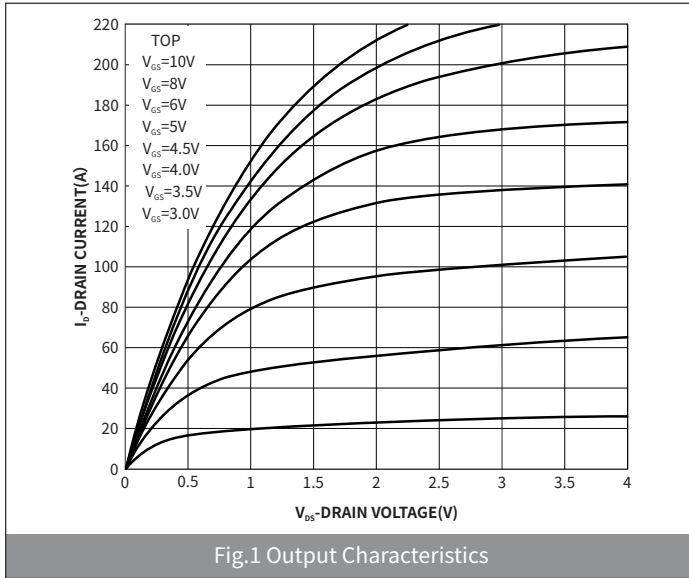
Note :

(1)Repetitive Rating: Pulse width limited by maximum junction temperature.

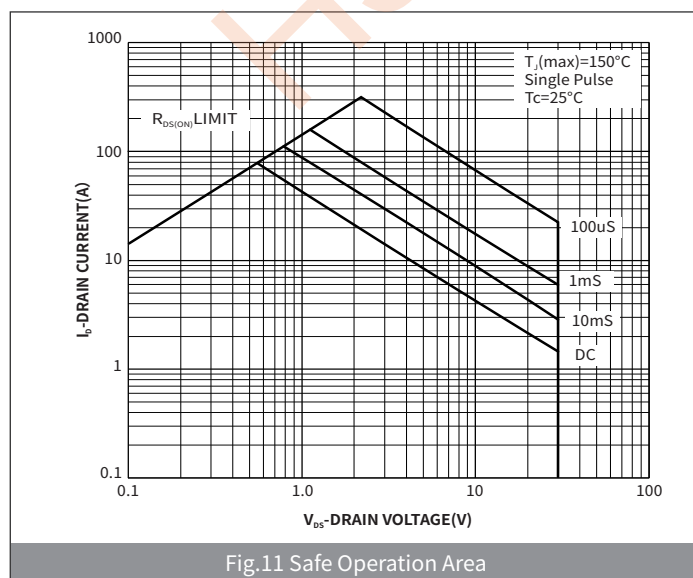
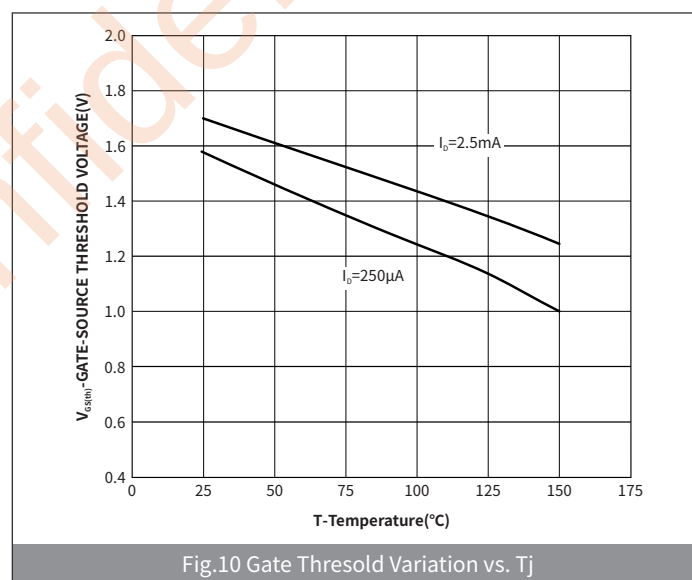
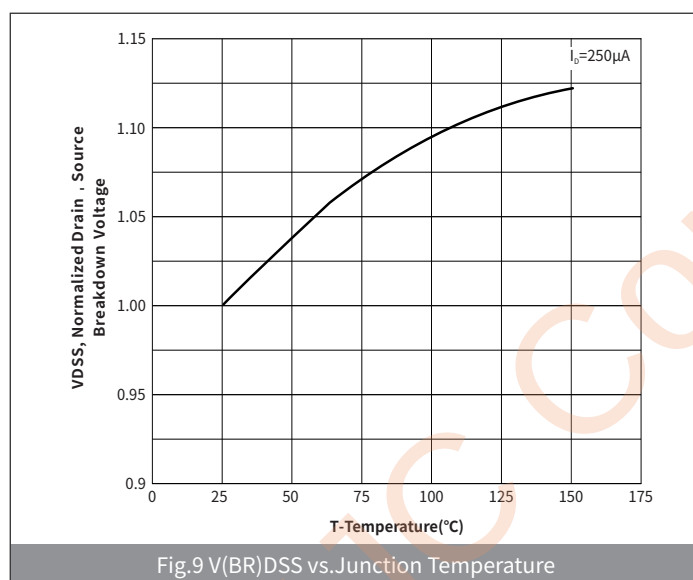
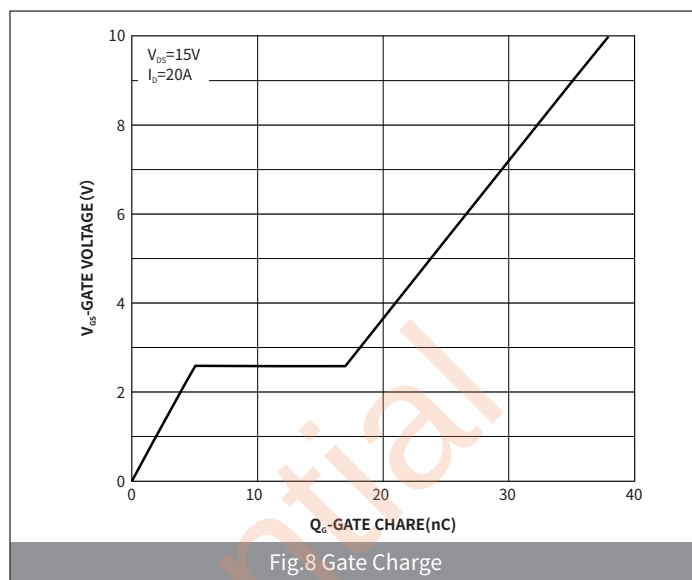
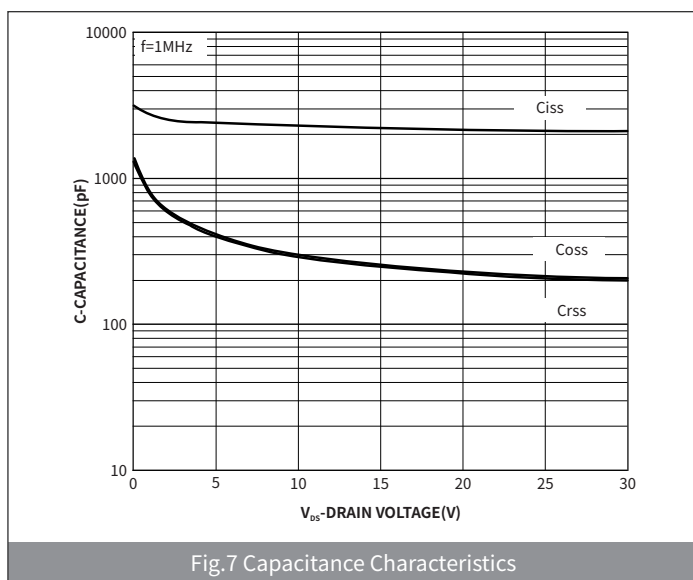
(2)EAS condition : T_j=25°C ,VDD=15V,VG=10V,L=0.5mH,IAS=19A,Rg=25Ω.

(3)Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.

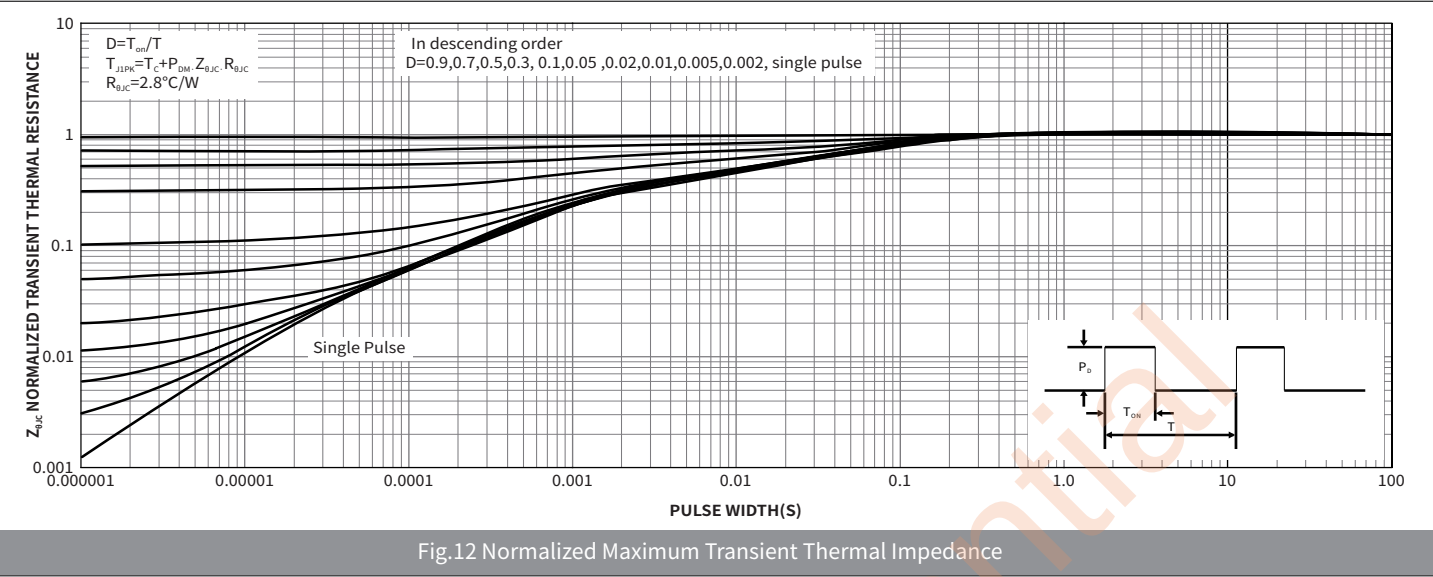
● Ratings And Characteristics Curves (Ta=25°C Unless otherwise specified)



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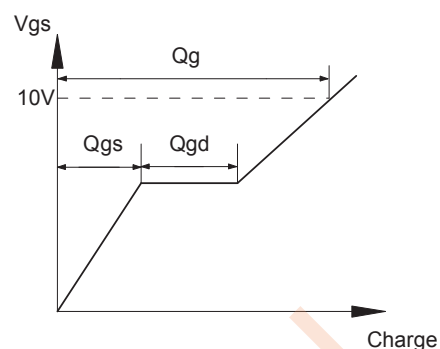
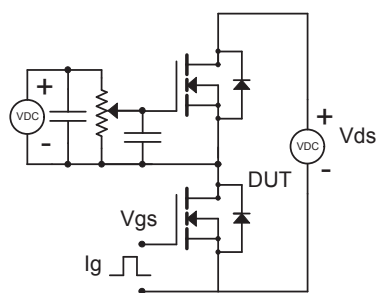
● Package Outline Dimensions (TO-252)

Symbol	Dimensions			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
A	6.50	6.70	0.253	0.262
B	5.10	5.46	0.199	0.213
C	1.40	1.80	0.054	0.070
D	6.00	6.20	0.234	0.242
E	10.00	10.40	0.390	0.406
F	2.16	2.36	0.084	0.092
G	0.66	0.86	0.025	0.033
φ	1.05	1.35	0.041	0.052
H	0.46	0.58	0.017	0.022
J	2.20	2.40	0.086	0.094
K	-	0.30	-	0.012
L	0.89	2.29	0.035	0.089
M	2.73	3.08	0.106	0.120
N	0.43	0.58	0.016	0.022

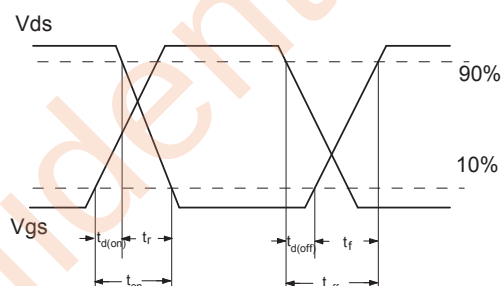
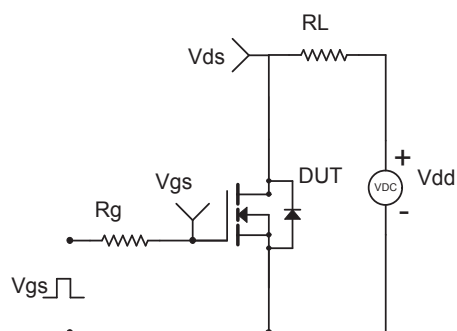
● Suggested Pad Layout

Symbol	Dimensions			
	Millimeters		Inches	
	Min.	Max.	Min.	Max.
a	3.70	-	0.145	-
b	4.37	-	0.171	-
X	-	5.80	-	0.227
X1	-	1.20	-	0.047
Y	-	5.85	-	0.229
Y1	-	2.00	-	0.078

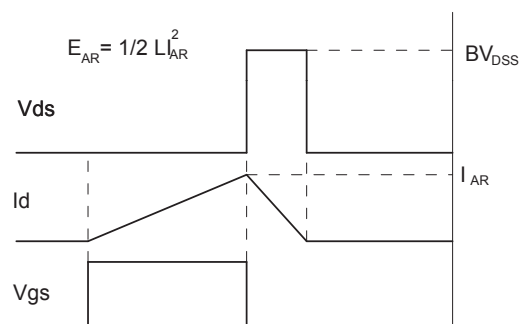
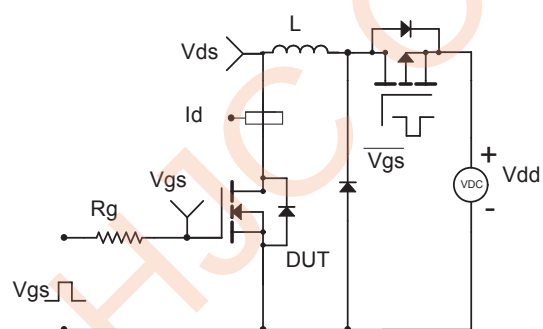
1. Gate Charge Test Circuit & Waveforms



2. Resistive Switching Test Circuit & Waveforms



3. Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



4. Diode Recovery Test Circuit & Waveforms

